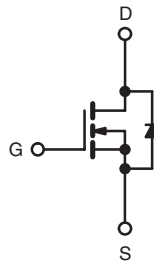
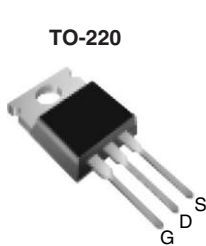




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## Power MOSFET

| PRODUCT SUMMARY           |                        |      |
|---------------------------|------------------------|------|
| $V_{DS}$ (V)              | 500                    |      |
| $R_{DS(on)}$ ( $\Omega$ ) | $V_{GS} = 10\text{ V}$ | 0.26 |
| $Q_g$ (Max.) (nC)         | 120                    |      |
| $Q_{gs}$ (nC)             | 34                     |      |
| $Q_{gd}$ (nC)             | 54                     |      |
| Configuration             | Single                 |      |



N-Channel MOSFET

### FEATURES

- Low Gate Charge  $Q_g$  Results in Simple Drive Requirement
- Improved Gate, Avalanche and Dynamic  $dV/dt$  Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Low  $R_{DS(on)}$
- Lead (Pb)-free Available



RoHS\*  
COMPLIANT

### APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply
- High Speed Power Switching
- Hard Switched and High Frequency Circuits

| ORDERING INFORMATION |                                 |
|----------------------|---------------------------------|
| Package              | TO-220                          |
| Lead (Pb)-free       | IRFB18N50KPbF<br>SiHFB18N50K-E3 |
| SnPb                 | IRFB18N50K<br>SiHFB18N50K       |

| ABSOLUTE MAXIMUM RATINGS $T_C = 25\text{ }^\circ\text{C}$ , unless otherwise noted |                                  |                                   |                  |                     |      |
|--|----------------------------------|-----------------------------------|------------------|---------------------|------|
| PARAMETER  | SYMBOL                           |                                   | LIMIT            | UNIT                |      |
| Drain-Source Voltage   | $V_{DS}$                         |                                   | 500              | V                   |      |
| Gate-Source Voltage  | $V_{GS}$                         |                                   | $\pm 30$         |                     |      |
| Continuous Drain Current   | $V_{GS}$ at 10 V                 | $T_C = 25\text{ }^\circ\text{C}$  | 17               | A                   |      |
|  |                                  | $T_C = 100\text{ }^\circ\text{C}$ | 11               |                     |      |
| Pulsed Drain Current <sup>a</sup>  | $I_{DM}$                         |                                   | 68               |                     |      |
| Linear Derating Factor   |                                  |                                   | 1.8              | W/ $^\circ\text{C}$ |      |
| Single Pulse Avalanche Energy <sup>b</sup>   | $E_{AS}$                         |                                   | 370              | mJ                  |      |
| Repetitive Avalanche Current <sup>a</sup>  | $I_{AR}$                         |                                   | 17               | A                   |      |
| Repetitive Avalanche Energy <sup>a</sup>   | $E_{AR}$                         |                                   | 22               | mJ                  |      |
| Maximum Power Dissipation  | $T_C = 25\text{ }^\circ\text{C}$ |                                   | $P_D$            | 220                 | W    |
| Peak Diode Recovery $dV/dt^c$  |                                  |                                   | $dV/dt$          | 7.8                 | V/ns |
| Operating Junction and Storage Temperature Range                                   | $T_J, T_{stg}$                   |                                   | - 55 to + 150    | $^\circ\text{C}$    |      |
| Soldering Recommendations (Peak Temperature)                                       | for 10 s                         |                                   | 300 <sup>d</sup> |                     |      |
| Mounting Torque  | 6-32 or M3 screw                 |                                   | 10               |                     |      |

#### Notes


- Repetitive rating; pulse width limited by maximum junction temperature.
- Starting  $T_J = 25\text{ }^\circ\text{C}$ ,  $L = 2.5\text{ mH}$ ,  $R_G = 25\text{ }\Omega$ ,  $I_{AS} = 17\text{ A}$ .
- $I_{SD} \leq 17\text{ A}$ ,  $dI/dt \leq 376\text{ A}/\mu\text{s}$ ,  $V_{DD} \leq V_{DS}$ ,  $T_J \leq 150\text{ }^\circ\text{C}$ .
- 1.6 mm from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

| THERMAL RESISTANCE RATINGS                    |            |      |      |      |
|---|------------|------|------|------|
| PARAMETER                                     | SYMBOL     | TYP. | MAX. | UNIT |
| Maximum Junction-to-Ambient <sup>a</sup>      | $R_{thJA}$ | -    | 58   | °C/W |
| Case-to-Sink, Flat, Greased Surface           | $R_{thCS}$ | 0.50 | -    |      |
| Maximum Junction-to-Case (Drain) <sup>a</sup> | $R_{thJC}$ | -    | 0.56 |      |

**Note**

a.  $R_{th}$  is measured at  $T_J$  approximately 90 °C.

| SPECIFICATIONS $T_J = 25\text{ °C}$ , unless otherwise noted |                       |  |   |      |           |               |
|--|-----------------------|--|---|------|-----------|---------------|
| PARAMETER  | SYMBOL                | TEST CONDITIONS  | MIN.  | TYP. | MAX.      | UNIT          |
| <b>Static</b>  |                       |  |   |      |           |               |
| Drain-Source Breakdown Voltage                               | $V_{DS}$              | $V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$  | 500   | -    | -         | V             |
| $V_{DS}$ Temperature Coefficient                             | $\Delta V_{DS}/T_J$   | Reference to 25 °C, $I_D = 1\text{ mA}$  | -   | 0.59 | -         | V/°C          |
| Gate-Source Threshold Voltage                                | $V_{GS(th)}$          | $V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$  | 3.0   | -    | 5.0       | V             |
| Gate-Source Leakage  | $I_{GSS}$             | $V_{GS} = \pm 30\text{ V}$   | -   | -    | $\pm 100$ | nA            |
| Zero Gate Voltage Drain Current                              | $I_{DSS}$             | $V_{DS} = 500\text{ V}, V_{GS} = 0\text{ V}$   | -   | -    | 50        | $\mu\text{A}$ |
|  |                       | $V_{DS} = 400\text{ V}, V_{GS} = 0\text{ V}, T_J = 125\text{ °C}$  | -   | -    | 250       |               |
| Drain-Source On-State Resistance                             | $R_{DS(on)}$          | $V_{GS} = 10\text{ V}, I_D = 10\text{ A}^b$  | -   | 0.26 | 0.29      | $\Omega$      |
| Forward Transconductance                                     | $g_{fs}$              | $V_{DS} = 50\text{ V}, I_D = 10\text{ A}$  | 6.4   | -    | -         | S             |
| <b>Dynamic</b>   |                       |  |   |      |           |               |
| Input Capacitance  | $C_{iss}$             | $V_{GS} = 0\text{ V}, V_{DS} = 25\text{ V}, f = 1.0\text{ MHz}, \text{ see fig. 5}$  | -   | 2830 | -         | pF            |
| Output Capacitance   | $C_{oss}$             |  | -   | 330  | -         |               |
| Reverse Transfer Capacitance                                 | $C_{rss}$             |  | -   | 38   | -         |               |
| Output Capacitance   | $C_{oss}$             | $V_{GS} = 0\text{ V}$  | $V_{DS} = 1.0\text{ V}, f = 1.0\text{ MHz}$ | -    | 3310      | -             |
|  |                       |  | $V_{DS} = 400\text{ V}, f = 1.0\text{ MHz}$ | -    | 93        | -             |
| Effective Output Capacitance                                 | $C_{oss\text{ eff.}}$ | $V_{DS} = 0\text{ V to } 400\text{ V}^c$   | -   | 155  | -         |               |
| Total Gate Charge  | $Q_g$                 | $V_{GS} = 10\text{ V}, I_D = 17\text{ A}, V_{DS} = 400\text{ V}, \text{ see fig. 6 and 13}^b$  | -   | -    | 120       | nC            |
| Gate-Source Charge   | $Q_{gs}$              |  | -   | -    | 34        |               |
| Gate-Drain Charge  | $Q_{gd}$              |  | -   | -    | 54        |               |
| Turn-On Delay Time   | $t_{d(on)}$           | $V_{GS} = 10\text{ V}, V_{DD} = 250\text{ V}, I_D = 17\text{ A}, R_G = 7.5\text{ }\Omega, \text{ see fig. 10}^b$                                     | -   | 22   | -         | ns            |
| Rise Time  | $t_r$                 |  | -   | 60   | -         |               |
| Turn-Off Delay Time  | $t_{d(off)}$          |  | -   | 45   | -         |               |
| Fall Time  | $t_f$                 |  | -   | 30   | -         |               |
| <b>Drain-Source Body Diode Characteristics</b>               |                       |  |   |      |           |               |
| Continuous Source-Drain Diode Current                        | $I_S$                 | MOSFET symbol showing the integral reverse p - n junction diode  | -   | -    | 17        | A             |
| Pulsed Diode Forward Current <sup>a</sup>                    | $I_{SM}$              |  | -   | -    | 68        |               |
| Body Diode Voltage   | $V_{SD}$              | $T_J = 25\text{ °C}, I_S = 17\text{ A}, V_{GS} = 0\text{ V}^b$   | -   | -    | 1.5       | V             |
| Body Diode Reverse Recovery Time                             | $t_{rr}$              | $T_J = 25\text{ °C}, I_F = 17\text{ A}, dI/dt = 100\text{ A}/\mu\text{s}^b$  | -   | 520  | 780       | ns            |
| Body Diode Reverse Recovery Charge                           | $Q_{rr}$              |  | -   | 5.3  | 8.0       | $\mu\text{C}$ |
| Forward Turn-On Time   | $t_{on}$              | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )  |   |      |           |               |

**Notes**

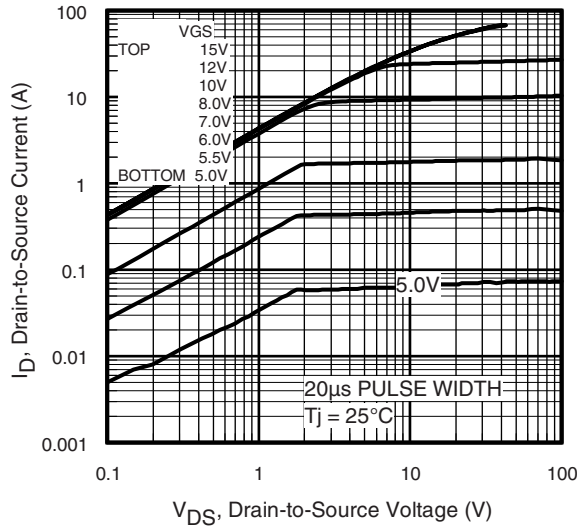
- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq 300\text{ }\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- c.  $C_{oss\text{ eff.}}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80 %  $V_{DS}$ .



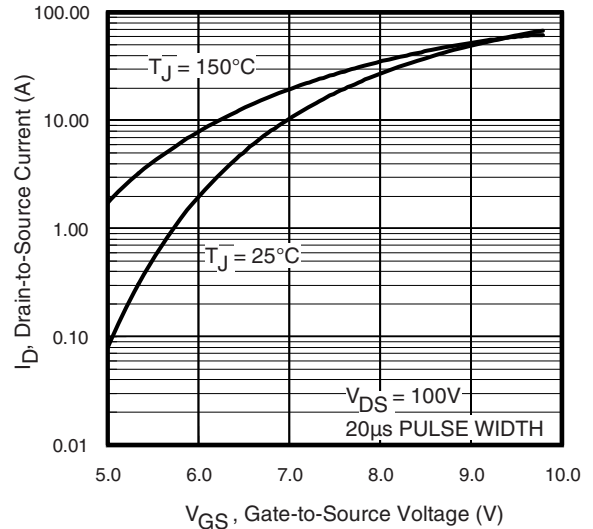
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# IRFB18N50K, SiHFB18N50K

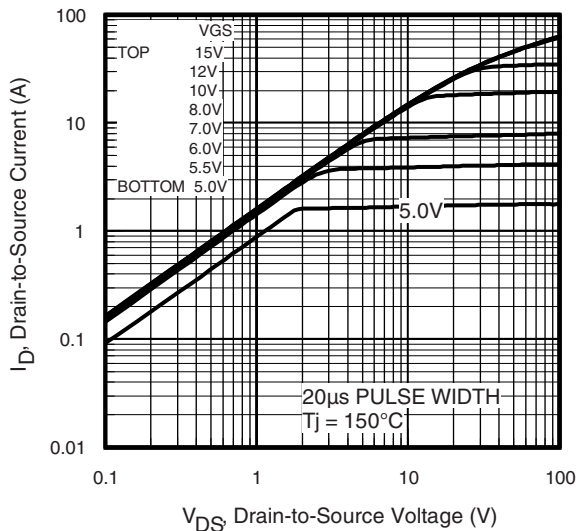
**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted



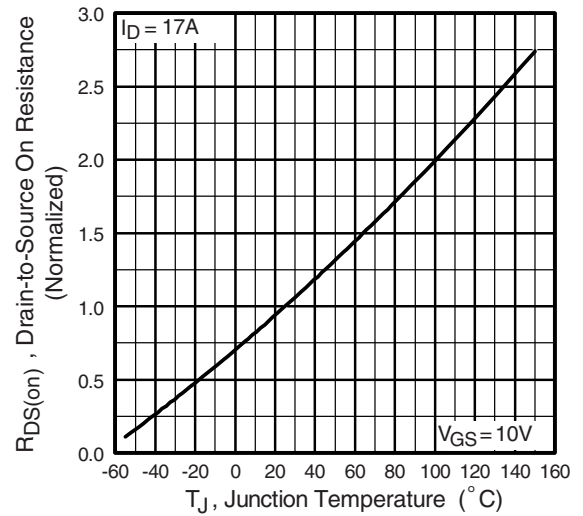
**Fig. 1 - Typical Output Characteristics**



**Fig. 3 - Typical Transfer Characteristics**



**Fig. 2 - Typical Output Characteristics**



**Fig. 4 - Normalized On-Resistance vs. Temperature**

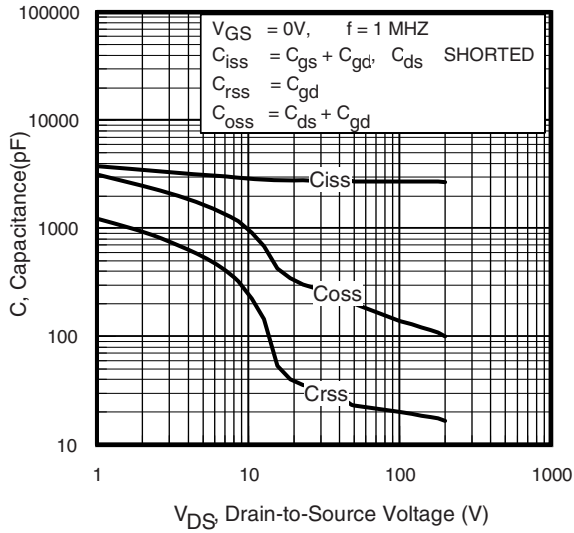


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

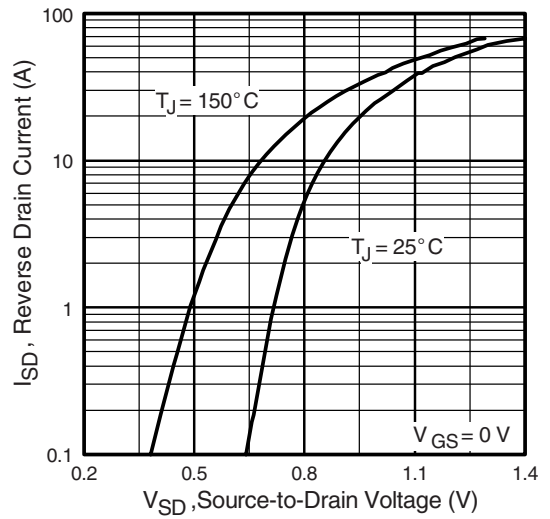


Fig. 7 - Typical Source-Drain Diode Forward Voltage

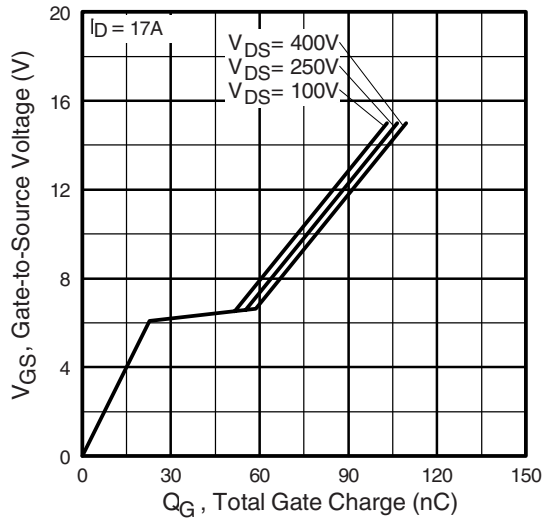


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

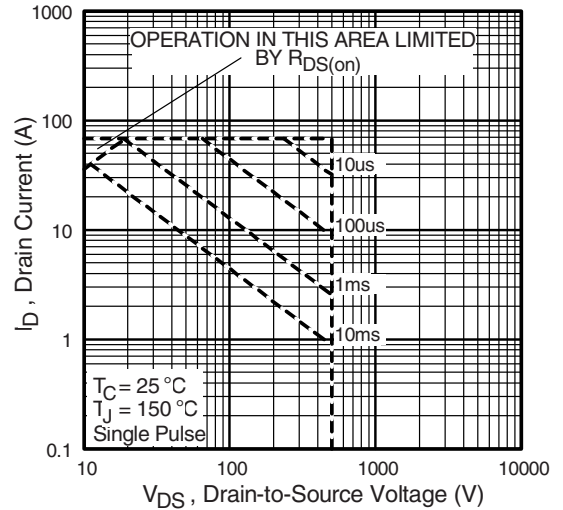
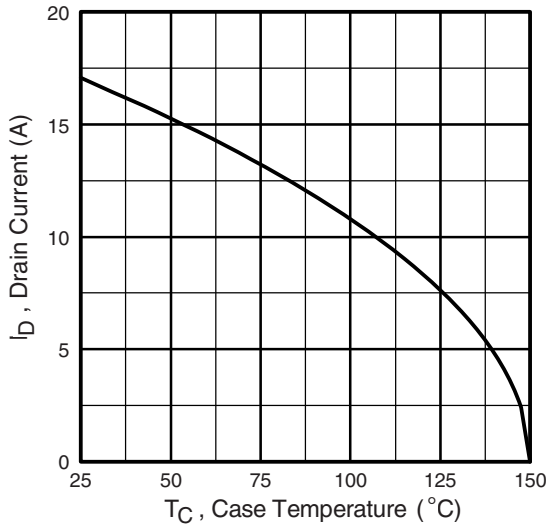
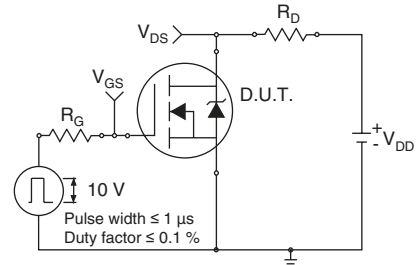


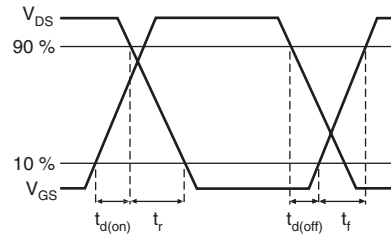
Fig. 8 - Maximum Safe Operating Area



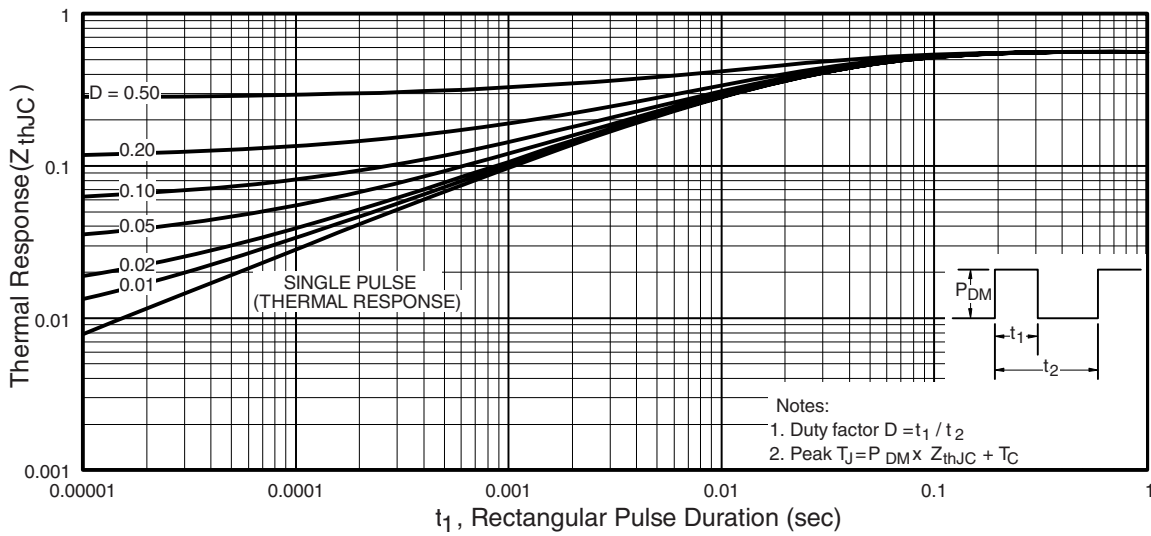
**Fig. 9 - Maximum Drain Current vs. Case Temperature**



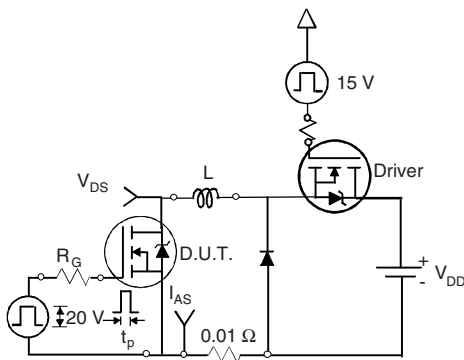
**Fig. 10a - Switching Time Test Circuit**



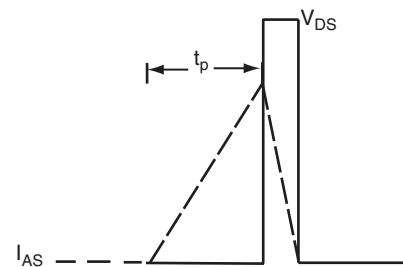
**Fig. 10b - Switching Time Waveforms**



**Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case**



**Fig. 12a - Unclamped Inductive Test Circuit**



**Fig. 12b - Unclamped Inductive Waveforms**

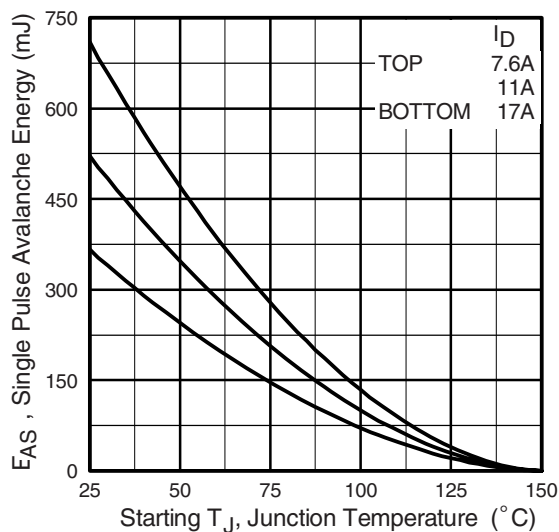


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

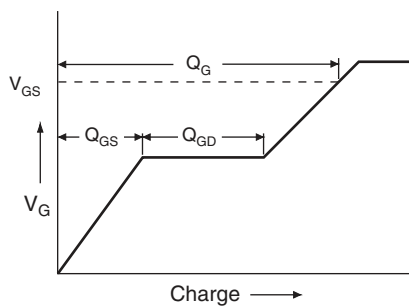


Fig. 13a - Basic Gate Charge Waveform

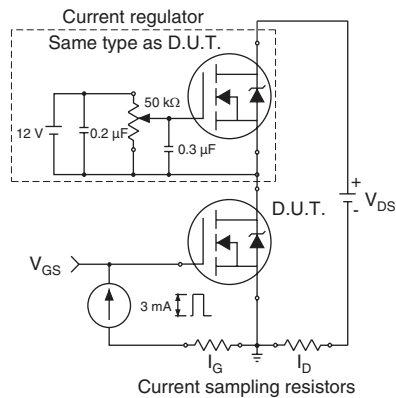
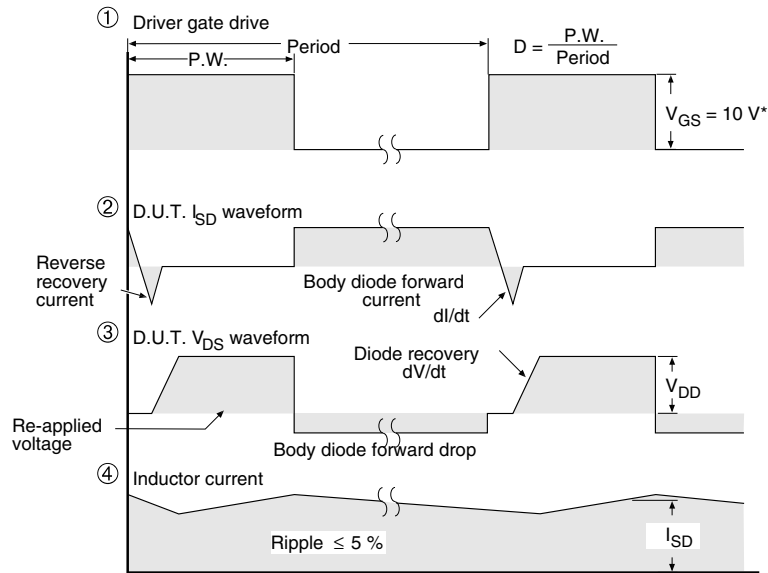
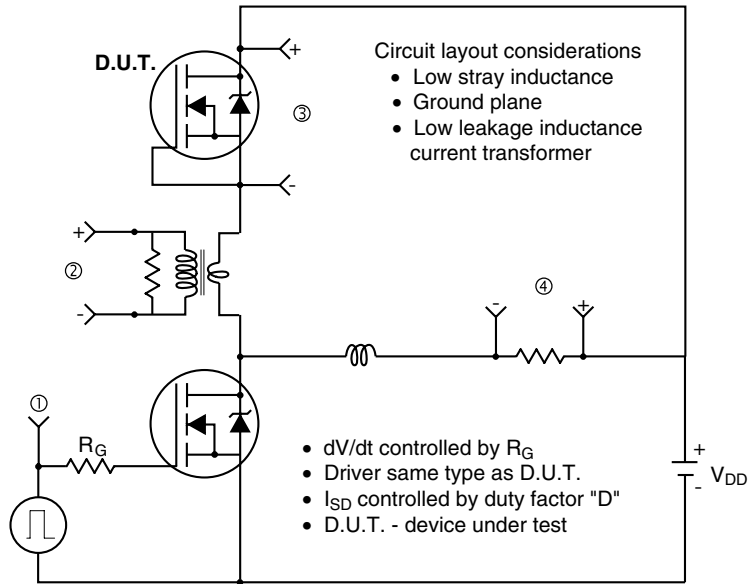


Fig. 13b - Gate Charge Test Circuit

## Peak Diode Recovery dV/dt Test Circuit



\*  $V_{GS} = 5 V$  for logic level devices

Fig. 14 - For N-Channel